10/010,343 AMENDMENT IN RESPONSE TO (OFFICE ACTION DATED FEBRUARY 27, 2003) **PATENT** 

## **AMENDMENTS TO THE SPECIFICATION**

Please amend the first full paragraph on page 6 as follows:

Second die 130 includes a second semiconductor substrate 132, and a microelectromechanical block 134 that is formed on second substrate 132. Microelectromechanical block 134, in turn, includes inductive structures, such as inductive structure 134A, that realize the functionality of a high Q inductor, and/or capacitive structures, such as capacitive structure 134B, that realize the functionality of a high Q capacitor.

